US	PΔ1	TENT	DOC	JMENTS
v.v.	-		$\omega\omega\omega$	コムにはコン

	T	i i							1	DOCOMEN12			
EXAMINER INITIAL		PATENT NUMBER							ISSUE DATE	PATENTEE	CLASS	SUB- CLASS	FILING DATE IF APPROPRIA TE
GLW	·	6	5	4	3	8	1	9	April 8, 2003	Hakimain	289	2	April 2, 2001
		6	4	3	5	5	7	1	Aug. 20, 2002	Parietti	289	17	Feb. 15, 2000
-		6	2	0	2	9	0	5	Mar. 20, 2001	Heide	223	94	Dec. 28, 1999
·	• :	6	. 1	2	0	0	6	8	Sept. 19, 2000	DiPietro	289	17	Nov. 24, 1999
		6	0	-,1	.5	1	7	2	Jan. 18, 2000	Williams et al.	289	2	May 20, 1997
		5	8	6	4	8	8	1	Feb. 2, 1999	Simmons	2	145	July 15, 1997
	1: 2:	5	6	9	2	2	4	1	Dec. 2, 1997	Helfer	2	152	April 8, 1996
		5	6	4	2	8	4 ·	1	July 1, 1997	Beaty	223.	85	July 1, 1996
		5	6	0.	1	3	1	8	Feb. 11, 1997	Rusing	289	17	Oct. 12, 1995
		5	5	7	7	7	7	8	Nov. 26, 1996	Parietti et al.	289	17	May 26, 1995
		5	5	6.	2	4	·5	6	Oct. 8, 1996	Cianciotto	434	260	April 12, 1995
		5	3	9	0	3	7	0	Feb. 21, 1995	Koy	2	152	Aug. 6, 1993
		4	8	1	5	7	7	2	Mar. 28, 1989	Lizamaga	289	1	Dec. 11, 1987
		4	4	7.	4	3	1	6	Oct. 2, 1984	Philibert	223	DIG	Sept. 13, 1982

FOREIGN PATENT OR PUBLISHED FOREIGN PATENT APPLICATION

:	DOCUMENT NUMBER						PUBLICATION COUNTRY OR PATENT OFFICE		CLASS	SUBCLASS	TRANSLATION YES NO	
	,									, .		
 									18			

			OTHER DOCUMENTS (Including Auth	or, Title, Date, Relevant Pages, Places of Publication)
:				See or assessor
				
		ليا		
EXAMINER		Xau	y two	DATE CONSIDERED 12/16/04
EXAMINER: In	tial citati	on core	sidered. Draw line through citation if not in confor	mance and not considered. Include copy of this form with next communication to applicant.

DATE CONSIDERED

EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

12/16/04

EXAMINER